

**Search Notes**

Application/Control No.

10/675,425

Examiner

Y Quach Lee

Applicant(s)/Patent under  
Reexamination

YEH, TZU-YUN

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	85 109 208 259 800	6/23/2005	YMY
372	108 109		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	6/23/2005	YMY